


<b>Search Notes</b>  	<b>Application/Control No.</b>  10672790	<b>Applicant(s)/Patent Under Reexamination</b>  BANNING ET AL.
	<b>Examiner</b>  Daniel Pan	<b>Art Unit</b>  2183

### SEARCHED

Class	Subclass	Date	Examiner
712	24,213 (partial search via East classification search and key word search)	04/09/08	dp
updated above		4/10/09	EC
updated above		10/26/09	EC
712	226 (partial search East classification search and key word search)	10/26/09	EC

### SEARCH NOTES

Search Notes	Date	Examiner
pgp uspat jopabs epoabs derwent IEEE IBM NPL 717/136, 711/202,206, 712/227,248,300	04/09/08	dp
Searched Google scholar (search terms instruction expand bit field vliw compression queue fifo)	4/10/09	EC
Searched Google scholar (search terms instruction expand bit field vliw compression queue fifo trigger rearrange machine vliw instruction)	10/26/09	EC
inventor name search	10/26/09	EC
Searched EAs US Pat file PG pub file EPO file JPO file IBM_TDB file	10/26/09	EC

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
712	24, 213, 226 via East US PG pub file	10/26/09	EC

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